## Notice of References Cited Application/Control No. 10/811,918 Applicant(s)/Patent Under Reexamination ONO ET AL. Examiner Rodney H. Bonck 3681 Applicant(s)/Patent Under Reexamination ONO ET AL.

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,085,879	07-2000	Ebinger et al.	192/3.3
*	В	US-6,142,272	11-2000	Meisner et al.	192/212
*	С	US-2001/0020563 A1	09-2001	Sasse et al.	192/212
	D	US-			
	ш	US-			
	F	US-			
	G	US-			
	Ι	US-	-		
	ı	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q					
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	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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